

Search Notes

Application/Control No.

10/050,334

Examiner

Yennhu B. Huynh

Applicant(s)/Patent under
Reexamination

AGARWAL ET AL.

Art Unit

2813

SEARCHED

Class	Subclass	Date	Examiner
257	295		
	296	3/2/05	YS
	301→		
	304		
	751		
	310-311		
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438	229	3/10/05	
	396→		
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	243		

665
964, 627, 653, 927**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
S. West/East USPAT EPO JPO Derwent I.P.M.I. (attach)	3/3/05	YP